Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/759,325	PAFF ET AL.	
Examiner	Art Unit	
Chun-Kuan (Mike) Lee	2181	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Updated EAST search:US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT Updated Inventor search utilizing eDan and EAST	12/5/2007	CKL
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